

## NDP7061 / NDB7061

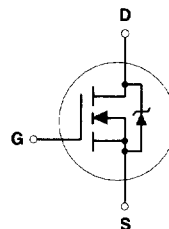
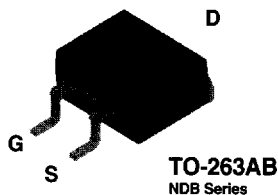
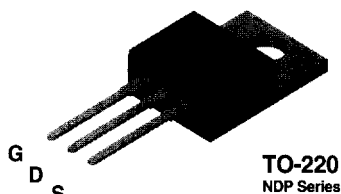
### N-Channel Enhancement Mode Field Effect Transistor

#### General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulses in the avalanche and commutation modes. These devices are particularly suited for low voltage applications such as automotive, DC/DC converters, PWM motor controls, and other battery powered circuits where fast switching, low in-line power loss, and resistance to transients are needed.

#### Features

- 64A, 60V.  $R_{DS(ON)} = 0.016\Omega @ V_{GS}=10V$ .
- Critical DC electrical parameters specified at elevated temperature.
- Rugged internal source-drain diode can eliminate the need for an external Zener diode transient suppressor.
- 175°C maximum junction temperature rating.
- High density cell design for extremely low  $R_{DS(ON)}$ .
- TO-220 and TO-263 (D<sup>2</sup>PAK) package for both through hole and surface mount applications.



#### Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	NDP7061	NDB7061	Units
$V_{DSS}$	Drain-Source Voltage		60	V
$V_{DGR}$	Drain-Gate Voltage ( $R_{GS} \leq 1\text{ M}\Omega$ )		60	V
$V_{GSS}$	Gate-Source Voltage - Continuous - Nonrepetitive ( $t_p < 50\ \mu\text{s}$ )		$\pm 20$	V
			$\pm 40$	
$I_D$	Drain Current - Continuous - Pulsed		64	A
			190	
$P_D$	Maximum Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$		130	W
			0.87	
$T_J, T_{STG}$	Operating and Storage Temperature Range		-65 to 175	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		275	$^\circ\text{C}$

**Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$W_{DSS}$	Single Pulse Drain-Source Avalanche Energy	$V_{DS} = 30\text{ V}, I_D = 64\text{ A}$			500	mJ
$I_{AR}$	Maximum Drain-Source Avalanche Current				64	A

**OFF CHARACTERISTICS**

$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	60			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 48\text{ V}, V_{GS} = 0\text{ V}$			10	$\mu\text{A}$
		$T_J = 125^\circ\text{C}$			1	$\text{mA}$
$I_{GSSF}$	Gate - Body Leakage, Forward	$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$			100	nA
$I_{GSSR}$	Gate - Body Leakage, Reverse	$V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$			-100	nA

**ON CHARACTERISTICS** (Note 1)

$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	2	2.9	4	V
		$T_J = 125^\circ\text{C}$	1.4	2.2	3.6	
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}, I_D = 35\text{ A}$		0.013	0.016	$\Omega$
		$T_J = 125^\circ\text{C}$		0.021	0.032	
$I_{D(ON)}$	On-State Drain Current	$V_{GS} = 10\text{ V}, V_{DS} = 10\text{ V}$	60			A
$g_{FS}$	Forward Transconductance	$V_{DS} = 10\text{ V}, I_D = 35\text{ A}$		30		S

**DYNAMIC CHARACTERISTICS**

$C_{iss}$	Input Capacitance	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$		1930		pF
$C_{oss}$	Output Capacitance			870		pF
$C_{rss}$	Reverse Transfer Capacitance			310		pF

**SWITCHING CHARACTERISTICS** (Note 1)

$t_{D(on)}$	Turn - On Delay Time	$V_{DS} = 25\text{ V}, I_D = 64\text{ A},$ $V_{GS} = 10\text{ V}, R_{GEN} = 5\ \Omega$		13	30	nS
$t_r$	Turn - On Rise Time			98	200	nS
$t_{D(off)}$	Turn - Off Delay Time			36	80	nS
$t_f$	Turn - Off Fall Time			65	150	nS
$Q_g$	Total Gate Charge	$V_{DS} = 48\text{ V},$ $I_D = 64\text{ A}, V_{GS} = 10\text{ V}$		67	100	nC
$Q_{gs}$	Gate-Source Charge			11		nC
$Q_{gd}$	Gate-Drain Charge			37.5		nC

Electrical Characteristics (T <sub>c</sub> = 25°C unless otherwise noted)						
Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>DRAIN-SOURCE DIODE CHARACTERISTICS</b>						
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				64	A
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current				190	A
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 35 A (Note 1)		0.9	1.3	V
			T <sub>J</sub> = 125°C	0.8	1.2	
t <sub>r</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>F</sub> = 64 A, di <sub>F</sub> /dt = 100 A/μs	40	105	150	ns
I <sub>r</sub>	Reverse Recovery Current		2	4.5	10	A
<b>THERMAL CHARACTERISTICS</b>						
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case				1.15	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient				62.5	°C/W
Note: 1. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%.						

Typical Electrical Characteristics

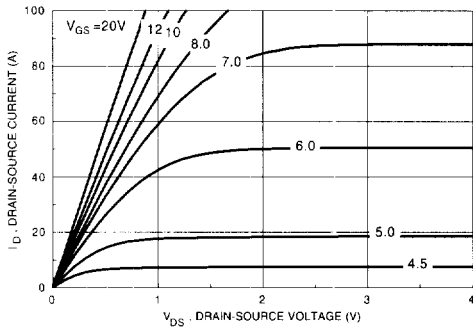


Figure 1. On-Region Characteristics

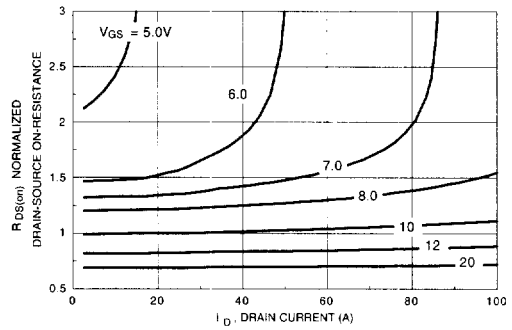


Figure 2. On-Resistance Variation with Gate Voltage and Drain Current

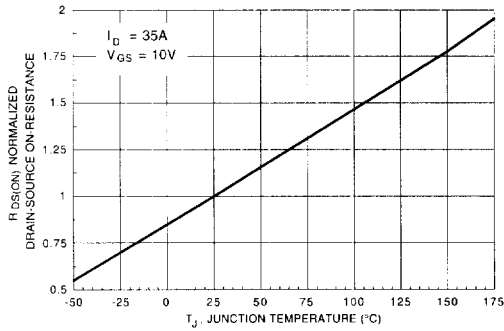


Figure 3. On-Resistance Variation with Temperature

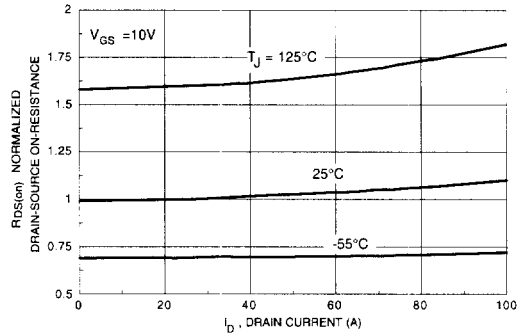


Figure 4. On-Resistance Variation with Drain Current and Temperature

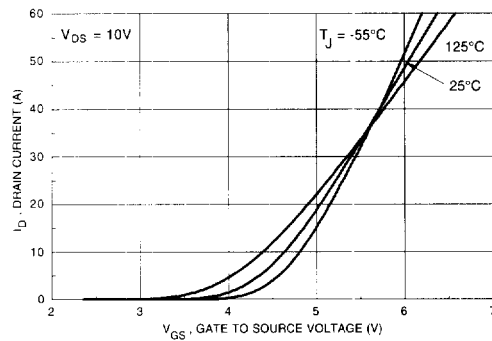


Figure 5. Transfer Characteristics

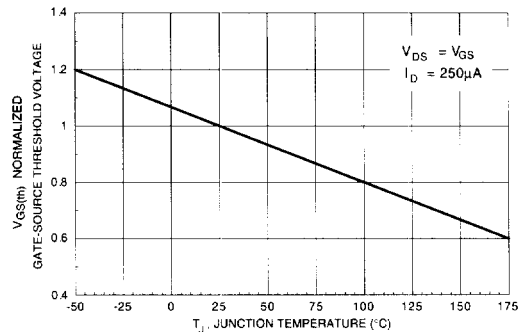
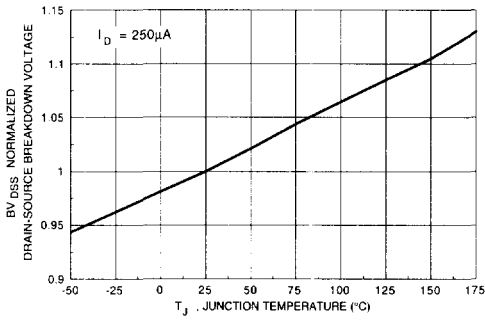


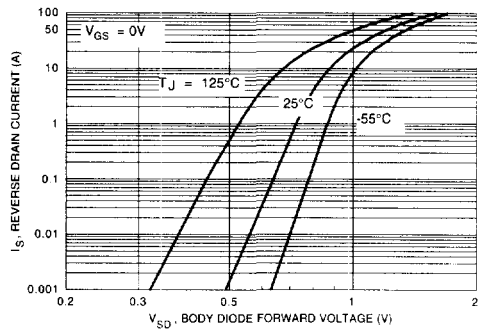
Figure 6. Gate Threshold Variation with Temperature

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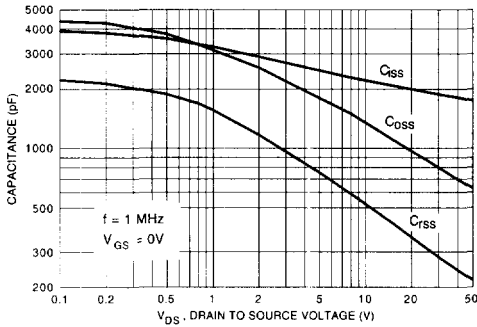
**Typical Electrical Characteristics (continued)**



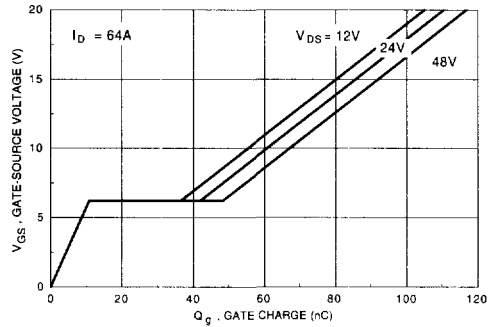
**Figure 7. Breakdown Voltage Variation with Temperature**



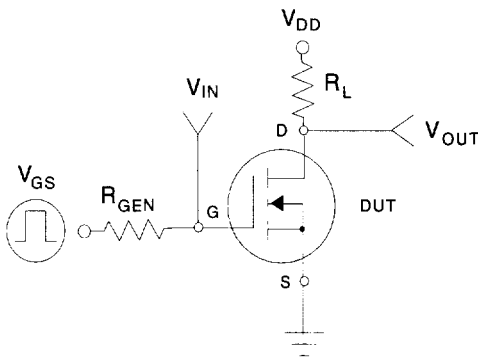
**Figure 8. Body Diode Forward Voltage Variation with Current and Temperature**



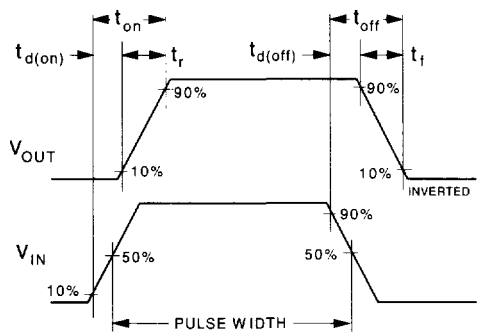
**Figure 9. Capacitance Characteristics**



**Figure 10. Gate Charge Characteristics**



**Figure 11. Switching Test Circuit**



**Figure 12. Switching Waveforms**

Typical Electrical Characteristics (continued)

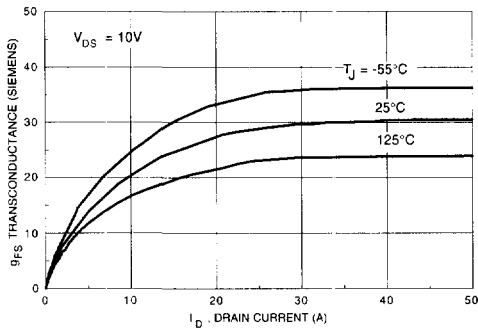


Figure 13. Transconductance Variation with Drain Current and Temperature

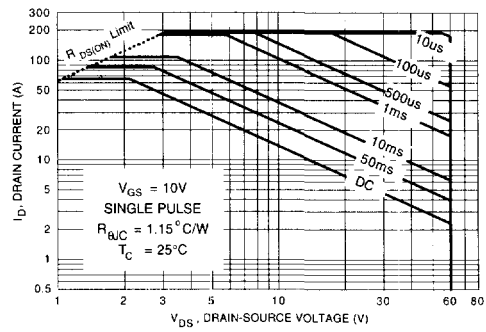


Figure 14. Maximum Safe Operating Area

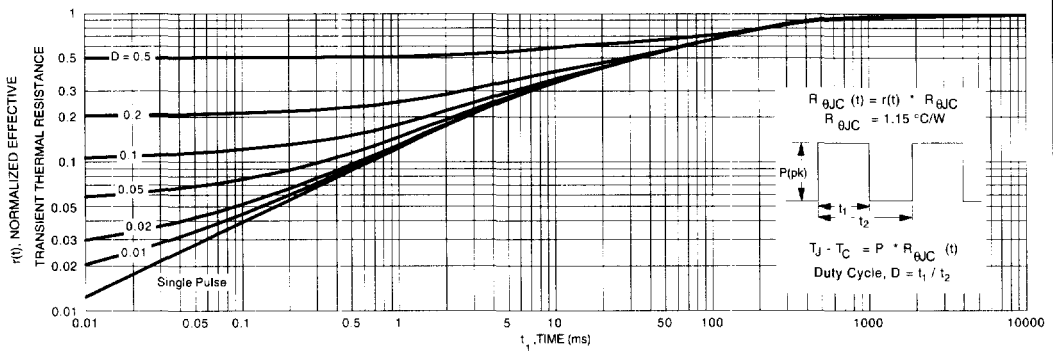


Figure 15. Transient Thermal Response Curve